

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/620,772	KAHN ET AL.
Examiner	Art Unit	
Ellen C. Tran	2134	

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	1/12/2007	ECT
All claims were reviewed for possible 101 rejections	1/12/2007	ECT
NPL - IEEE & GOOGLE	1/12/2007	ECT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner